

Notice of References Cited

Application/Control No.

09/402,482

Applicant(s)/Patent Under
Reexamination
GROHMANN ET AL.

Examiner

Virginia M Kibler

Art Unit

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,583,904	12-1996	Adams, John A.	378/22
	B	US-			
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	D	US-			
	E	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Neubauer et al., "X-ray inspection of solder joints by planar computer tomography (PCT)", IEEE, 1994, pages 60-64.
	V	Neubauer, "Intelligent X-Ray Inspection for Quality Control of Solder Joints," IEEE, April 1997, pages 111-120
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	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.